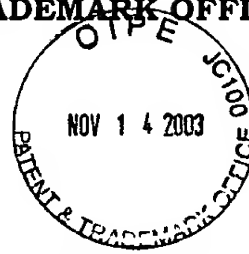


**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

**Appl. N . : 09/742,224**  
**Applicant : Walx FANG ET AL**  
**Filed : December 22, 2000**  
**Title : METHOD FOR DETERMINING FAILURE RATE**  
**AND SELECTING BEST BURN-IN TIME**  
**TC/A.U. : 2857**  
**Examiner : Baran, Mary C**  
**Docket No. : 4425-102**



Honorable Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

RECEIVED  
NOV 19 2003  
TECHNOLOGY CENTER 2800

**AMENDMENT**

Sir:

In response to the Official Action mailed August 14, 2003. Preliminary to examining this application Applicants respectfully request that the Examiner reconsider the amended application according to the following remarks.

Please amend the above-identified application as follows: